

Notice of References Cited	Application/Control No. 10/042,153		Applicant(s)/Patent Under Reexamination SAIKATSU ET AL.	
	Examiner Katarzyna Wyrozebski Lee		Art Unit 1714	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,596,789	07-2003	Nakamura et al.	523/155
	B	US-6,451,872	09-2002	Yamane, Takeshi	523/156
	C	US-			
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	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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